## Applicant(s)/Patent Under Reexamination 10/643,911 PARK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 3744 Chen-Wen Jiang

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-5,309,733 A	05-1994	Hayashida et al.	62/278
	В	US-5,297,392 A	03-1994	Takata et al.	62/160
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р							
	Q							
	R							
-	S							
	Т							

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	>						
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	Х						

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